

LIST OF ART CITED BY APPLICANT

(PTO-1449)

10541572 - GAU: 2624

ATTY. DOCKET NO.
SEKI-0011APPLN. SERIAL NO.
10/541,572APPLICANT(S)
Kenichi UEDAINTL. FILING DATE
2/17/2004
U.S. NATL. PHASE FILING
DATE:
2/7/2005~~GROUP 3161~~

U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | *PATENT NO. | *ISSUE DATE | *INVENTOR NAME | CLASS | SUBCLASS | FILING DATE |
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U.S. PATENT APPLICATION PUBLICATIONS

| | *PATENT APPLN. PUB. NO. | *PUB. DATE | *APPLICANT | CLASS | SUBCLASS | |
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U.S. PATENT APPLICATIONS

| | *APPLN. NO. | *FILING DATE | *INVENTOR | CLASS | SUBCLASS | |
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FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation | |
|------------------------|--|------------|-------------------------|-------|----------|--------------|----|
| | | | | | | Yes | No |
| /E.M./ | CN 1248752A (Appln No. CN 19981020704) | 2000-03-29 | China (entire document) | | | Abst ract | |
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

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EXAMINER

/Eric Mohr/

DATE CONSIDERED

04/23/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

LIST OF ART CITED BY APPLICANT
(PTO-1449)

10541572 - GAU: 2624

ATTY. DOCKET
SEKI-0011

APPL. SERIAL NO.
Natl. Phase of Intl.
Appln. No.
PCT/JP2004/001684

APPLICANT(S)
Kenichi UEDA

INTL. FILING DATE
2/17/2004
U.S. NATL. PHASE FILING
DATE:
2/7/2005

GROUP

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U.S. PATENT APPLICATIONS

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FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation | |
|------------------------|----------------|----------|---------|-------|----------|-------------|----|
| | | | | | | Yes | No |
| | JP2003-6567 | 01-10-03 | Japan | | | X | |
| | JP 09-251522 | 09-22-97 | Japan | Q | | X | |
| | JP 2001-195536 | 07-19-01 | Japan | | | X | |
| | JP 07-036383 | 02-07-95 | Japan | | | X | |
| | JP 2000-076411 | 03-14-00 | Japan | | | X | |

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

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EXAMINER /Eric Mohr/

DATE CONSIDERED 04/23/2008

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /E.M./